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## Bi<sub>2</sub>Ti<sub>2</sub>O<sub>7</sub>薄膜的制备及在栅场效应管中的应用

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### Preparation of Bi<sub>2</sub>Ti<sub>2</sub>O<sub>7</sub> Thin Film and Its Application in Insulation Gate Field Effect Transistor

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- 摘要
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**全文:** PDF (282 KB) **HTML (1 KB)** **输出:** BibTeX | EndNote (RIS) **背景资料**

**摘要** 采用化学溶液沉积法,用价格低廉的原料成功地制备了Bi<sub>2</sub>Ti<sub>2</sub>O<sub>7</sub>介电膜,制膜过程简单,成本低廉,得到的薄膜具有良好的绝缘性和较高的介电常数,用其制备的绝缘栅场效应管与相同尺寸的SiO<sub>2</sub>绝缘栅场效应管相比,前者具有较高的跨导和较低的开启电压.

**关键词:** Bi<sub>2</sub>Ti<sub>2</sub>O<sub>7</sub>薄膜 介电常数 绝缘栅场效应管

**Abstract:** The Bi<sub>2</sub>Ti<sub>2</sub>O<sub>7</sub> thin film was successfully prepared by chemical solution deposition technique on n-Si (100) using bismuth nitrate and titanium butoxide as the starting materials. The film presents very good insulating property and has relatively high dielectric constant. Compared with the SiO<sub>2</sub> insulation gate field effect transistor of the same size,it can greatly increase the transconductance and lower the cut-in voltage.

**Key words:** Bi<sub>2</sub>Ti<sub>2</sub>O<sub>7</sub>thin film; dielectric constant insulation gate field effect transistor

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